MSKSEMI 美森科













ESD

TVS

TSS

MOV

GDT

PLED

AONR36366-MS

Product specification





Description

The AONR36366-MS uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

Features

- V_{DS} = 30V I_D =100A
- R_{DS(ON)} < 5 . 5 mΩ @ V_{GS}=10V

Application

- Battery protection
- Load switch
- Uninterruptible power supply

Reference News

PACKAGE OUTLINE	P-Channel MOSFET	Marking
DFN3X3-8L	G	100N03 XXXX ●

Absolute Maximum Ratings (TC=25℃ unless otherwise specified)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage 30		V
Vgs	Gate-Source Voltage ±20		V
l₀@Tc=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	100	A
lo@Tc=100°C	Continuous Drain Current, V _{GS} @ 10V ¹	70	A
l□@T _A =25°C	Continuous Drain Current, V _{GS} @ 10V ¹ 30		A
l₀@T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹ 25		A
Ідм	Pulsed Drain Current ² 192		Α
EAS	Single Pulse Avalanche Energy ³ 144.7		mJ
las	Avalanche Current 53.8		A
PD@Tc=25°C	Total Power Dissipation ⁴ 62.5		W
Po@Ta=25°C	Total Power Dissipation ⁴ 4.5		W
Тята	Storage Temperature Range -55 to 150		°C
TJ	Operating Junction Temperature Range -55 to 150		°C
Reja	Thermal Resistance Junction-ambient ¹ 62		°C/W
Rejc	Thermal Resistance Junction-Case ¹ 2.4		°C/W



Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Id=250uA	30			V
∆BVdss/∆Tj	BVDSS Temperature Coefficient	Reference to 25°C, l⊳=1mA		0.0213		V/°C
		Vgs=10V , Id=30A		4	5.5	
Rds(on)	Static Drain-Source On- Resistance ²	Vgs=4.5V,Id=15A		5.2	6	mΩ
VGS(th)	Gate Threshold Voltage		1.0		2.5	V
ΔV GS(th)	VGS(th) Temperature Coefficient	Vgs=Vds,Id =250uA		-5.8		mV/°C
loss	Drain Source Lookage Current	Vds=24V,Vgs=0V, TJ=25°C			1	uA
1033		Vds=24V,Vgs=0V, TJ=55°C			5	uA
lgss	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	Vds=5V, Id=30A		26.5		S
Rg	Gate Resistance	V _{DS} =0V,V _{GS} =0V, f=1MHz		1.4		Ω
Qg	Total Gate Charge (4.5V)			31.6		
Qgs	Gate-Source Charge	Vɒs=15V,Vσs=4.5V, Iɒ=15A		8.6		nC
Qgd	Gate-Drain Charge			11.7		-
Td(on)	Turn-On Delay Time			9		
Tr	Rise Time	Vdd=15V,Vgs=10V, Rg=3.3Ω		19		
Td(off)	Turn-Off Delay Time			58		ns
Tf	Fall Time	_ l ⊳=15A		15.2		
Ciss	Input Capacitance			3075		
Coss	Output Capacitance	Vɒs=15V,Vɕs=0V, _f=1MHz		400		pF
Crss	Reverse Transfer Capacitance			315		
ls	Continuous Source Current ^{1,6}	Vg=Vp=0V , Force			100	А
lsм	Pulsed Source Current ^{2,6}	Current			192	А
Vsd	Diode Forward Voltage ²	Vgs=0V,Is=1A, TJ=25°C			1	V

Diode Characteristics Note ;

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3.The EAS data shows Max. rating . The test condition is VDD=25V,VGS=10V,L=0.1mH,IAS=34A

4.The power dissipation is limited by 150 $^{\circ}\mathrm{C}$ junction temperature

5 .The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.



Typical Characteristics

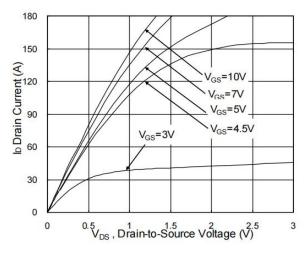


Fig.1 Typical Output Characteristics

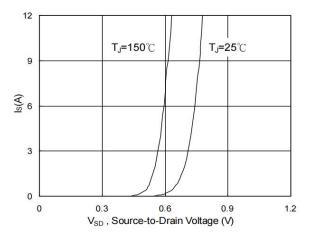


Fig.3 Forward Characteristics of Reverse

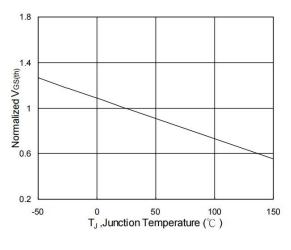


Fig.5 Normalized VGS(th) vs. TJ

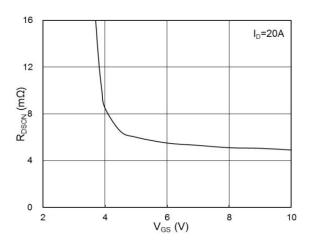


Fig.2 On-Resistance vs. G-S Voltage

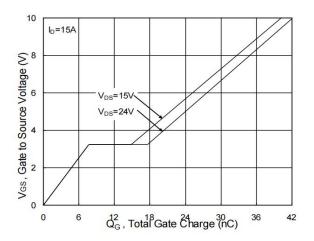


Fig.4 Gate-Charge Characteristics

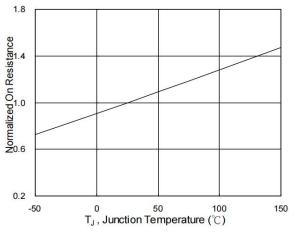
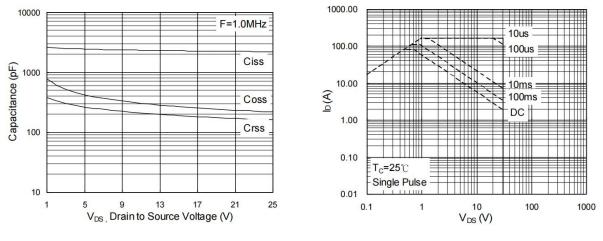


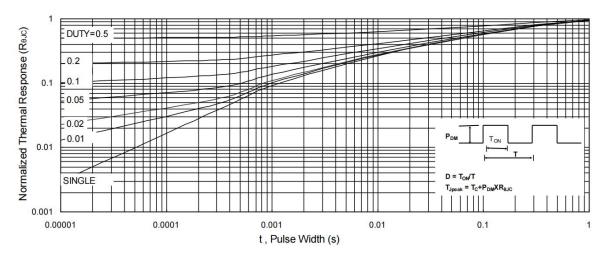
Fig.6 Normalized RDSON vs. TJ



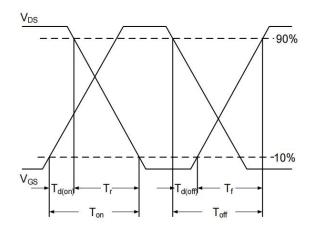














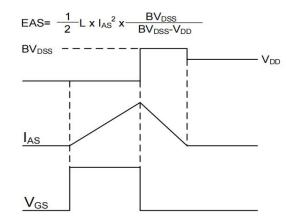
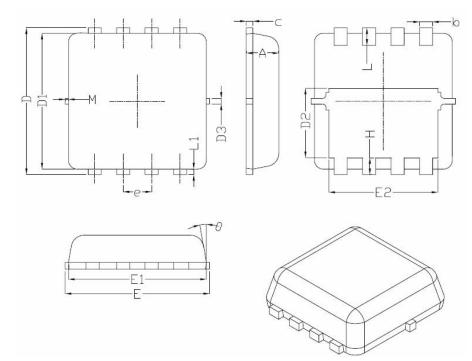


Fig.11 Unclamped Inductive Switching Waveform



DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
Α	0.70	0.75	0.80	
b	0.25	0.30	0.35	
с	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
e	0.65BSC			
н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	_	0.13	_	
М	*	*	0.15	
θ		10 [°]	12 [°]	

REEL SPECIFICATION

P/N	PKG	QTY
AONR36366-MS	DFN3X3-8L	5000



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